Multifunctional high-frequency circuit capabilities of ambipolar carbon nanotube FETs

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Abstract

An experimentally-calibrated carbon nanotube compact transistor model has been used here to design two high-frequency (HF) circuits with two different functionalities each: a phase configurable amplifier (PCA) and a frequency configurable amplifier (FCA). The former design involves an in-phase amplifier and an inverting amplifier while the latter design embraces a frequency doubler as well as a distinct inverting amplifier. The specific functionality selection of each of the two HF circuit designs is enabled mainly by the inherent ambipolar feature at a device level. Furthermore, at a circuit level the matching networks are the same regardless the operation mode. In-phase and inverting amplification are enabled in the PCA by switching the gate-to-source voltage (V_{GS}) from -0.3 V to 0.9 V while the drain-to-source voltage (V_{DS}) remains at 3 V. By designing carefully the matching and stability networks, power gains of ∼4.5 dB and ∼6.7 dB at 2.4 GHz for the in-phase and inverting operation mode have been achieved, respectively. The FCA, in its frequency doubler operation mode, exhibits ∼20 dBc of fundamental-harmonic suppression at 2.4 GHz when an input signal at 1.2 GHz is considered. This frequency doubler functionality is enabled at $V_{\text{GS}} = 0.3 \text{ V}$, whereas at $V_{\rm GS} = 0.9 \text{ V}$ amplification of ~4.5 dB is obtained while $V_{\rm DS}$ remains at 3 V in both cases. In both configurable circuits the stabilization and matching networks are the same regardless the bias-chosen operation mode. The circuits performance degradation due to metallic tubes in the device channel is studied as well as the impact of non-ideal inductors in each design. PCA and FCA operation modes are further exploited in high-frequency modulators.

Index Terms

CNTFET, ambipolar electronics, multifunctional circuit, high-frequency amplifier, frequency multiplier, FSK, PSK.

I. INTRODUCTION

Carbon nanotubes (CNTs) have emerged as one of the options to replace the silicon (Si)-based channel of novel field-effect ansistors (FETs) in high-performance applications beyond the limits of conventional technologies $[1]$, $[2]$ while improving further the device footprint and fabrication costs of related circuits [\[3\]](#page-7-2). The quasi-ballistic transport, an outstanding gate control over the channel, as well as an inherent device linearity associated to CNTFETs, makes them suitable for low-power high-frequency (HF) applications [\[2\]](#page-7-1), [\[4\]](#page-7-3), [\[5\]](#page-7-4) as recently demonstrated by devices operating at frequencies of around 100 GHz [\[6\]](#page-7-5)–[\[8\]](#page-7-6). One feature of carbon-based FETs is their ambipolar behavior [\[9\]](#page-7-7)–[\[12\]](#page-7-8), i.e., the device performance in the active region can be of *n*-type-like or *p*-type-like according to the bias. Notice that CNTFETs in this work have only three terminals (source, drain and gate), in contrast to previous reports where an additional control gate has been used to control the ambipolarity [\[13\]](#page-7-9), [\[14\]](#page-7-10).

In-phase and inverting amplification can be enabled in ambipolar transistors by applying an input AC signal and biasing the device in the linear *n*-type region and linear *p*-type region, respectively. Furthermore, if the DC device operation is around the minimum transconductance point, the frequency (f) of an input AC signal can be multiplied at the output [\[15\]](#page-7-11). Therefore, on-chip designs can benefit from ambipolar devices since stages of radio-frequency (RF) integrated circuits, including frequency multipliers and amplifiers, can be fabricated with the same transistor technology biased at different regions, hence reducing the fabrication process and production costs.

CNTFETs ambipolarity [\[10\]](#page-7-12), [\[16\]](#page-7-13)–[\[19\]](#page-7-14) has been already used in proof-of-concept analog circuits [\[15\]](#page-7-11), [\[20\]](#page-7-15)–[\[22\]](#page-7-16) focused on the frequency multiplying characteristic rather than tackling efficient circuit design to exploit the device multifunctionality for analog circuits. In this work, two CNTFET-based HF circuit designs, identified here as a phase configurable amplifier (PCA) and a frequency configurable amplifier (FCA), are presented. The device biasing conditions enable two different circuit operation modes in each design: an in-phase amplifier (PA) and an inverting amplifier (IA) are possible in the PCA while a frequency doubler (FD) and a distinct IA can be selected in the FCA. The different functionalities for the PCA and the FCA have been demonstrated with identical matching networks and further exploited for the proposal of CNTFET-based modulators.

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Hence, this is an efficient on-chip solution for CNTFET-based configurable HF analog circuits by using a suitable compact large-signal model [\[23\]](#page-7-17).

This work intends to show the capabilities of ambipolar CNTFETs in high-frequency circuits by considering optimal and quasi-optimal conditions at both device and circuit level. The outcome of this study should be considered as a support and motivation for the CNTFET community related to fabrication and circuit design since these results have been obtained considering feasible scenarios.

II. COMPACT MODEL AND DEVICE DESCRIPTION

Electron and hole transport is inherently allowed simultaneously in CNTs. The dominant carrier type in CNTFETs is determined by the contacts physics [\[10\]](#page-7-12), [\[16\]](#page-7-13), [\[17\]](#page-7-18). In the transfer curves shown in Fig. [1\(](#page-1-0)a), the drain current (I_D) is comprised mainly by tunneling electron current at the saturation regime of the *n*-branch, due to a strong energy bands bending (thin source potential barrier). The ohmic region of the *p*-branch is due to a thin drain barrier induced by high negative gate-to-source voltage V_{GS} enabling a major contribution of tunneling hole current.

Fig. 1. (a) Simulated transfer characteristics from CCAM for the reference MT-CNTFET without metallic tubes. Markers indicate the different bias points considered in this work. (b) Representation of the v_{in} (black) and ideal v_{out} (colored) for the device biased at the different operation regions.

In this work, a semi-physical large-signal compact model for CNTFETs, named CCAM [\[23\]](#page-7-17), [\[24\]](#page-7-19) has been used. It describes the ambipolar behavior of a fabricated CNTFET technology considering, by different modules, both the contribution of semiconductor (s-) and metallic (m-) tubes in the channel. These modules correspond to the intrinsic part of the device as identified in the compact model equivalent circuit shown in Fig. [2\(](#page-2-0)a). Discussions on each model parameter and the physics behind each of them have been provided in [\[23\]](#page-7-17), [\[24\]](#page-7-19). High-frequency noise modules, described elsewhere [\[28\]](#page-7-20) have been activated in this work. The compact model has been calibrated (including both intrinsic part and parasitics) to hysteresis-free DC and dynamic experimental data [\[23\]](#page-7-17), [\[25\]](#page-7-21) from a fabricated top-gate multi-tube (MT) CNTFET technology [\[26\]](#page-7-22), hence, the model used here is directly related to a manufacturable optimized device technology^{[1](#page-1-1)}. CNTFET-based RF applications have been already developed using this technology [\[26\]](#page-7-22), [\[29\]](#page-7-23)–[\[31\]](#page-7-24). HF performance projections for amplifiers using the considered CNTFET technology have been developed using CCAM [\[27\]](#page-7-25), [\[28\]](#page-7-20), however, the ambipolarity features of CNTFETs have not been exploited in such works. The reference device considered here has a channel length of 700 nm and a top-gate length of 250 nm , a total of eight gate fingers, $50 \mu \text{m}$ of width each, yielding a device total width of $400 \mu \text{m}$. The device cross-section is shown in Fig. [2\(](#page-2-0)b). Diameters of the tubes have been estimated of ∼1.8 nm [\[23\]](#page-7-17), leading to a channel bandgap of ∼0.47 eV. The channel array has s- and m-tubes grown on $SiO₂$ substrate via chemical vapor deposition. Fabrication process details can be found in [\[26\]](#page-7-22).

A high number of s-CNTs in the channel is required towards improving the HF device performance, as demonstrated by an s-tube sensitivy study for RF circuits presented elsewhere [\[27\]](#page-7-25) and fabricated RF state-of-the-art devices [\[6\]](#page-7-5)–[\[8\]](#page-7-6), [\[32\]](#page-7-26). Hence, the number of m-CNTs in the compact model has been set to zero while other parameters remain unchanged for enhancing the HF performance, i.e., an optimized device with only 2000 s-CNTs in the channel, leading to a tube density n_t of 5 CNTs/µm, has been considered in this study. Transfer characteristics of the simulated ambipolar MT-CNTFET, considering only s-tubes in the channel, are shown in Fig. [1\(](#page-1-0)a) where three bias points, related to a different operation region each, have been indicated. Region I corresponds to the *p*-type behavior, region II embraces the polarity transition (low-transconductance regime) and region III includes the *n*-type dominant branch. At high V_{DS} , tunneling processes are more pronounced as observed by the higher value of the minimum current at the corresponding transfer characteristic in contrast to curves at lower V_{DS} . The expected outcome of an input AC signal for the device biased differently is qualitatively shown in Fig[.1\(](#page-1-0)b).

III. CNTFET-BASED MULTIFUNCTIONAL CIRCUITS

The ambipolar behavior of CNTFETs enhances the development of multifunctional analog circuits by biasing the device in one of the three regions identified in Fig. [1.](#page-1-0) In regions I and III, the dependence of I_D on V_{GS} is ideally described by a linear

¹The compact model used here is one of the few able to correctly describe the performance of fabricated RF CNTFET technology

Fig. 2. (a) Equivalent circuit of the large-signal model CCAM. The intrinsic part (inside the dashed box) includes a module for parameters associated to semiconducting tubes (in red in the electronic version) and another one related to metallic tubes (in blue in the electronic version). See [\[23\]](#page-7-17), [\[24\]](#page-7-19) for detailed discussions on each parameter as well as for the experimental validation of the model. (b) Schematic cross-section of the CNTFET used for the CCAM calibration used in this work (not drawn to scale).

function with a negative (region I) or positive (region III) slope, i.e., $I_D = -g_m V_{GS} + B$ or $I_D = g_m V_{GS} + E$, respectively. In region II, I_D has a parabolic-like V_{GS} -dependence, i.e., $I_D = C + D(V_{GS} - V_{GS_0})^2$, with the constants B, C, D and E and $V_{\rm GS_0} = V_{\rm GS}|_{\rm min(I_D)}$. Thus, considering $V_{\rm in} = V_{\rm GS} + v_{\rm in} = V_{\rm GS} + A \sin \omega t$, in regions I and III, the device operates as a g_m -controlled amplifier: being an in-phase amplifier for $g_m < 0$ (in region I), while in region III ($g_m > 0$) the device works as an inverting amplifier. An improved device linearity (constant g_m [\[4\]](#page-7-3)) enhance the amplifying performance. Furthermore, if the device is biased in region II, it works during half period of the input signal in the p -like region and during the other half period in the n-like region, yielding a doubled frequency in the output signal enhanced by the parabolic-shape transfer characteristics within this bias. Due to the common source topology, by using a drain resistor R_D to apply V_{DS} from a V_{DD} voltage source (see Fig. [3\)](#page-3-0), the output voltage in region II is $V_{\text{out}} = V_{\text{DS}} + v_{\text{out}} = V_{\text{DD}} - BR_{\text{D}} - 1/2 (R_{\text{D}}CA^2) + 1/2 (R_{\text{D}}CA^2 \cos 2\omega t)$, i.e., the doubled frequency is explained by the fourth term. A similar analysis of the output signals for different operation modes of ambipolar CNTFETs has been provided elsewhere [\[15\]](#page-7-11).

A. Phase configurable amplifier design

The selected bias points of the PCA are $V_{\text{GS}} = -0.3 \text{ V}$ (region I) for the PA operation mode and $V_{\text{GS}} = 0.9 \text{ V}$ (region III) for the IA operation mode, in both cases $V_{DS} = 3 V$. Cutoff and maximum oscillation frequencies obtained at the bias point in region I(III) are $4 \text{ GHz} (8.5 \text{ GHz})$ and $14.6 \text{ GHz} (23.5 \text{ GHz})$, respectively. Both amplifiers have been designed for maximum gain at 2.4 GHz. The device unilateral power gain at 2.4 GHz are 19 dB and 10 dB for the PCA-PA and PCA-IA, respectively. Ambipolar CNTFETs have been used previously to design in-phase and inverting amplifiers at low operation frequencies [\[15\]](#page-7-11), biasing the device at high V_{DD} (12 V), lacking gain for the in-phase configuration and requiring specific matching networks for each operation mode. In contrast, in this work the considered device is used to design a PCA suitable for RF applications at lower V_{DD} (= V_{DS} = 3 V) and with identical matching and stabilization networks regardless the operation mode, i.e., a more efficient design for multifunctional CNTFET-based circuits is proposed here.

Fig. [3](#page-3-0) shows the proposed PCA design operating at a f of 2.4 GHz. The parameters values are listed in Table [I\(](#page-3-1)a). The design has been developed using the Verilog-A implementation [\[24\]](#page-7-19) of CCAM [\[23\]](#page-7-17) into the Keysight Advance Design System software. Based on the internal transport mechanisms at each contact, source and drain contacts remain physically the same regardless the operation mode. However, at a circuit level and considering the difference in the external potentials, a commonsource (common-drain) circuit topology is related for the CNTFET working in region I (III). A feedback topology using a resistor R₁, a capacitor C₁ and an inductor L₁ has been designed in order to find stability conditions (K > 1 and $|\Delta|$ < 1, see [\[33\]](#page-7-27)). The PCA is unconditionally stable at 2.4 GHz , and up to 3 GHz , while V_{GS} changes indistinctly the operation mode (see Fig. [4\(](#page-3-2)a)). Furthermore, matching networks have been designed towards a transparent implementation with established 50Ω -RF systems. Notice that the stability and matching networks remain the same regardless the operation mode (bias). For higher frequencies however, matching and stability network designs, different to the ones considered here, are required to avoid non-desired oscillations.

The PCA is able to change its operation mode only by switching the device bias between regions I and III. In both cases, $|S_{11}|$ and $|S_{22}| \lesssim -10$ dB at 2.4 GHz as shows Fig. [4\(](#page-3-2)b). The power gain for the in-phase amplifier operation mode is ∼4.5 dB whereas for the inverting amplifier mode is ∼6.7 dB (see Fig. [5\(](#page-3-3)a)). In contrast to voltage-gainless fabricated CNTFET-based ambipolar amplifiers designed for specific functionalities [\[15\]](#page-7-11), voltage gain of ∼1.7 V/V and ∼2.16 V/V has been obtained here, for the in-phase and inverting amplifier, respectively. By switching operation modes, the amplified output signal phase is shifted from 0[°] ($V_{\text{GS}} = -0.3 \text{ V}$) to 180[°] ($V_{\text{GS}} = 0.9 \text{ V}$) (see Fig. [5\(](#page-3-3)b)). The input power (P_{in}) has been of -15 dBm at 2.4 GHz.

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Fig. 3. Schematic of the PCA and FCA. Possible operation modes for the PCA ($R_D = 0 \Omega$) are as an in-phase or as an inverting amplifier. The FCA $(R_{\rm D} \neq 0 \Omega)$ can operate as a frequency doubler or as an inverting amplifier. All operation modes are controlled by $V_{\rm GS}$ in each configuration. Matching (dotted and dash-dotted line boxes) and stabilization (continuous line box) networks are the same regardless the operation mode of each design. Parameter values are reported in Table [I.](#page-3-1)

TABLE I PARAMETER VALUES OF THE DESIGNED CIRCUITS

Fig. 4. (a) Stability metrics and (b) $|S_{11}|$ and $|S_{22}|$ for PCA operation modes: in-phase amplifier (V_{GS} = -0.3 V) and inverting amplifier (V_{GS} = 0.9 V).

Fig. 5. (a) $|S_{21}|$ and (b) v_{in} and v_{out} signals for the two PCA operation modes: in-phase amplifier ($V_{\text{GS}} = -0.3 \text{ V}$) and inverting amplifier ($V_{\text{GS}} = 0.9 \text{ V}$). Circles in (a) indicate the gain at 2.4 GHz. (a slight phase shift caused by the matching networks, the same in both operation modes, has been corrected for a better visualization of the circuit performance).

B. Frequency configurable amplifier design

The schematic of the FCA is similar to the PCA design, (Fig. [3\)](#page-3-0), however, parameter values are different (see Table I(b)). Notice specially the inclusion of R_D in this design. The selected bias points are $V_{\text{GS}} = 0.3 \text{ V}$ (region II) for the frequency doubler operation mode and $V_{\text{GS}} = 0.9 \text{ V}$ (region III) for the inverting amplifier operation mode, in both cases $V_{\text{DS}} = 3 \text{ V}$. The FCA name has been proposed since the output signal is at doubled or similar f as the input signal, depending on the operation mode. The feedback network has been designed in order to have both stability conditions and an improved output signal in the FD operation mode. The matching network has been designed towards the enhancement of both operation modes. P_{in} is -10 dBm at 1.2 GHz.

The frequency doubler performance ($V_{\text{GS}} = 0.3 \text{ V}$), can be observed by comparing the input and output signals frequency shown in Fig. [6\(](#page-4-0)a). The slight difference in the amplitudes between two successive periods is related to a non-symmetric ambipolar device performance (see Fig. [1\(](#page-1-0)a)). The reference device has not been optimized towards an ideal ambipolar symmetry since this technology has been proposed for general RF applications [\[26\]](#page-7-22), e.g., [\[29\]](#page-7-23)- [\[31\]](#page-7-24). The output power (P_{out}) for the frequency doubler operation mode is −14.6 dBm at 2.4 GHz leading to a circuit conversion frequency loss of 4.6 dB, while almost all the power is concentrated at 2.4 GHz as shown in Fig. [6\(](#page-4-0)b). The FCA design is a more efficient frequency doubler than the reported circuits in [\[21\]](#page-7-28) with considerable lower conversion losses (-35 dB and -55 dB, regardless the different n_t) at similar operation frequency. Additionally, the performance in P_{out} and operation frequency obtained here are higher than the ones of CNTFET-based frequency doublers presented elsewhere [\[22\]](#page-7-16), [\[34\]](#page-7-29). Furthermore, the voltage gain of the frequency doubler operation mode is of ∼0.6 V/V which, despite its low value, is almost 4 times higher than the one achieved at 2 kHz with a different CNTFET technology [\[15\]](#page-7-11). Multi-stage HF amplifiers solutions, with the same CNTFET technology [\[27\]](#page-7-25), [\[28\]](#page-7-20), can be proposed towards improving the FCA-FD performance.

Fig. 6. (a) v_{in} and v_{out} signals for the two operation modes of the FCA: frequency doubler ($V_{\text{GS}} = 0.3$ V) and inverting amplifier ($V_{\text{GS}} = 0.9$ V) (a slight phase shift, caused by the matching networks, has been corrected in the plot for a better visualization of the circuit performance). (b) P_{out} spectrum of the frequency doubler operation mode for a P_{in} of -10 dBm at 1.2 GHz.

Fundamental-harmonic suppression for the frequency doubler operation mode is 19.65 dBc while the 3rd and 4th harmonic suppression are 20.14 dBc and 25.64 dBc, respectively. This indicates a high spectral purity for the doubled frequency P_{out} . Notice that this harmonic suppression is higher than in previous CNTFET-related works [\[21\]](#page-7-28), [\[22\]](#page-7-16) where devices with high n_t have been considered. Device parasitics have been considered in the compact model, hence the achieved harmonic suppression is due to a proper matching network design, which produces $|S_{11}|$ and $|S_{22}| < -10$ dB at 1.2 GHz and 2.4 GHz, respectively (see Fig. [7\(](#page-5-0)a)), in addition to the device properties. Notice that the results obtained for this circuit with this specific operation mode can be further improved if a more symmetric ambipolar response of the device can be achieved by, e.g., a modulation of the internal charge, however this is out of the scope of this study.

The FCA can be switched into amplification mode by biasing the device in region III ($V_{\text{GS}} = 0.9 \text{ V}$). The device is stable at 1.2 GHz and $|S_{11}|$ and $|S_{22}| \le -10$ dB at 1.2 GHz as shows Fig[.7\(](#page-5-0)a). The unilateral power gain of the device in this bias point and at 1.2 GHz is of 7.4 dB. Power gain of ∼4.5 dB at 1.2 GHz (see Fig[.7\(](#page-5-0)b)) is achieved with the FCA inverting amplifier operation mode. Noise figures of merit NF_{min} , R_{n} and Γ_{opt}) of the FCA-IA are 10.3 dB, 191.4 Ω and 0.186 (−21.88°), respectively. As discussed in Section [III.](#page-1-2)A, CNTFET-based amplifiers can be designed towards optimum noise performance as shown elsewhere [\[28\]](#page-7-20).

The performance of the FCA circuit can be controlled by the selected bias point without changes in the stability and matching networks resulting in a V_{GS}-controlled circuit capable to operate as an amplifier at 1.2 GHz or as a frequency doubler with an

Fig. 7. (a) $|S_{11}|$ and $|S_{22}|$ for the two operation modes of the FCA. (b) $|S_{21}|$ for the FCA-IA (the circle indicates the gain at 1.2 GHz).

output f of 2.4 GHz . A third operation mode for the multifunctional circuits presented here, involves a more intricate trade-off between impedance matching and stability for each functionality and it is out of the scope of this work.

IV. IMPACT OF M-TUBES AND INDUCTOR QUALITY FACTOR

In order to consider a non-optimized techology, a study of the impact of m-tubes in the device channel on multifunctional circuits has been carried out here by considering a semiconducting-to-metallic tube ratio (s:m) of 3:1, i.e., the original calibration of the compact model (cf. Section [II\)](#page-1-3) [\[23\]](#page-7-17) has been used. Fig. [8\(](#page-5-1)a) shows that device operation regions remain similar in shape with higher I_D values at the same bias in comparison to the optimal case (cf. Fig. [1\(](#page-1-0)a)). At a circuit level however, higher V_{DD} are required for the FCA design (8.6 V for the FD and 7.6 V for the IA). The overall performance of both multifunctional circuits is degraded with the presence of m-tubes (Figs. [8\(](#page-5-1)b)-(d)) in contrast to the CNTFET with s-tubes only, considered in previous sections. E.g., for the non-optimzed technology, gains of 5.7 dB and 3.3 dB have been obtained for the PCA-IA and PCA-PA, respectively, and a conversion loss of 6.2 dB is achieved for the FCA-FD. The latter is obtained at the cost of more power consumption.

Fig. 8. Results with a s:m-ratio of 3:1 in the device channel: (a) CNTFET transfer characteristics, (b) v_{in} and v_{out} signals and (d) $|S_{21}|$ for the PCA operation modes, and (c) output spectrum of the FCA frequency doubler mode.

The impact of inductor quality factor (Q) on the performance of multifunctional circuits has been studied here by considering high-Q on-chip CNT-based inductors [\[35\]](#page-7-30) in the proposed designs $(L_1$ in Fig. [3\)](#page-3-0). Results are shown in Table [II](#page-6-0) for Q of 8 and 35 (see Fig. 12 in [\[35\]](#page-7-30)) as well as the ideal case of CNT inductors. All inductors can be assumed to be over $SiO₂$ substrates towards an integrated fabrication. The gain of the PCA's both modes is degraded \sim 3 dB in the worst scenario (lowest Q). Similarly, the FCA-IA gain is diminished ~ 1.5 dB for $Q = 8$ while the FCA-FD conversion loss is ~ 3 dB more than the ideal case. In the case of $Q = 35$ the performance is slightly deviated from the ideal case response.

V. CNTFET-BASED MODULATORS ENABLED BY THE MULTIFUNCTIONAL CIRCUITS

In order to show potential applications of the PCA and FCA with their different operation modes in high-data rate communication systems, two different modulation schemes have been demonstrated: phase-shift keying (PSK) and frequencyshift keying (FSK). The device compact model with semiconducting CNTs in the channel (Sections II and III) has been considered in this part of the work.

TABLE II IMPACT OF Q-FACTOR ON PCA AND FCA OPERATION MODES AT 2.4 GHz

Fig. 9. Modulation schemes achieved with CNTFET-based multifucntional circuits. (a) PSK modlated signal (v_{out}) achieved with the PCA by varying the operation mode between IA ($V_{\text{GS}} = 0.9 \text{ V}$ equivalent to a digital "1") and PA ($V_{\text{GS}} = -0.3 \text{ V}$ equivalent to a digital "0"). (b) FSK modulated signal (v_{out}) achieved with the FCA by varying the operation mode between IA ($V_{\rm GS} = 0.9$ V equivalent to a digital "1") and FD ($V_{\rm GS} = 0.3$ V equivalent to a digital "0").

The input has been fed with AC carrier signals (not shown here) with frequency of 2.4 GHz for the PSK and of 1.2 GHz for the FSK as well as the baseband data given by the variation of V_{GS} . In all cases, $V_{\text{DS}} = 3 \text{ V}$. By switching V_{GS} alternatively between 0.9 V (IA operation mode) to −0.3 V (PA operation mode) the binary values "1" and "0" can be stablished with the PCA leading to a PSK modulated signal at the output as shown in Fig. [9\(](#page-6-1)a). Similarly, FSK modulation has been achieved by considering the two functionalities of the FCA as shown in Fig. [9\(](#page-6-1)b). Hence, the CNTFET-based circuit designs proposed in this work enable to perform modulation schemes, PSK with PCA or FSK with FCA, revealing them as suitable solutions for on-chip communication systems since only one single device and circuit have been used for each modulation. According to the authors' knowledge, this is the first proposal of CNTFET-based modulators.

VI. CONCLUSIONS

CNTFETs are promising candidates to develop multifunctional HF applications due to their intrinsic ambipolar transport. The circuits presented here include a PCA and a FCA. The PCA works at a f of 2.4 GHz for its two operation modes: as an in-phase amplifier and as an inverting amplifier. The FCA works at 1.2 GHz for its two operation modes: as a frequency doubler and as an inverting amplifier. Similar matching networks have been used for both functionalities of each design. According to the authors' knowledge, this is the first proposal of CNTFET-based HF multifunctional circuits which configurability is only bias-controlled and without the need of changing matching and stabilization networks. These networks however, should be designed considering an enhanced performance for the two functionalities of each circuit. The results obtained here show the feasibility of multifunctional ambipolar CNTFET-based circuits for RF applications in S-band using a systematic study based on a device compact model calibrated with reproducible experimental data from a manufacturable CNTFET technology. This is of special interest towards multifunctional high-performance power-efficient on-chip solutions, e.g., in FSK or PSK modulators using a single device as shown in this work. Hence, this work's proposal can alleviate fabrication and production costs in HF integrated circuits based in CNTFETs or other ambipolar devices, e.g., graphene FETs.

In the case of the PCA, voltage and power gains $\langle 21.7 \text{ V/V} \rangle$ and $\langle 4.5 \text{ dB} \rangle$, respectively) have been achieved through a carefully bias point selection and stabilization and matching networks design. Moreover, fundamental-harmonic suppression close to 20 dBc has been observed for the frequency doubler operation mode of the FCA, which indicates that doubler frequency circuits based on CNTFETs can be used without additional filtering stages. Moreover, both the impact of m-tubes in the device channel and CNTs-based inductors with different Q on the circuits response have been studied. Results indicate that the multifuctionality feature of the designed circuits can be achieved with discrete success, in comparison to the optimized case, with at least 1/3 of m-tubes in the channel array and with non-ideal CNT-based inductors.

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